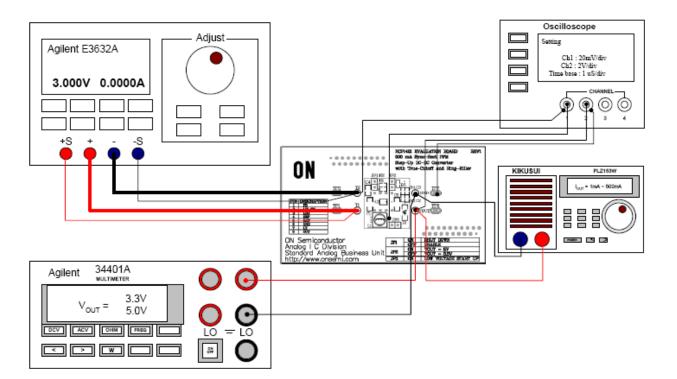


ON Semiconductor



Test Procedure for the NCP1422 Evaluation Board

- 1. Connect the test setup as shown above.
- 2. TURN OFF the JP; (enable the device).
- 3. Set the Power Supply to 3.0V and apply to TP1, TP2, (T1, T2).
- 4. Apply 500mA loading form the electric load.
- 5. Check the input current (I_{IN}) , output voltage (V_{OUT}) and output ripple;
 - For V_{OUT} = 3.3V; **JP2 OFF** I_{IN} = 590.7mA ~ 608.7mA V_{OUT} = 3.267 ~ 3.367V $V_{RIPPLE} \le 35mV$
 - For V_{OUT} = 5V; **JP2 ON** I_{IN} = 931.07mA ~ 957.4mA V_{OUT} = 4.859 ~ 5.0075V $V_{RIPPLE} \le 40mV$
- 6. Check the switching waveform at scope CH1 to see whether it is a normal continuous conduction mode switching node waveform and switching ON time (T_{ON}) is between 0.46 µs ~ 1.15 µs